

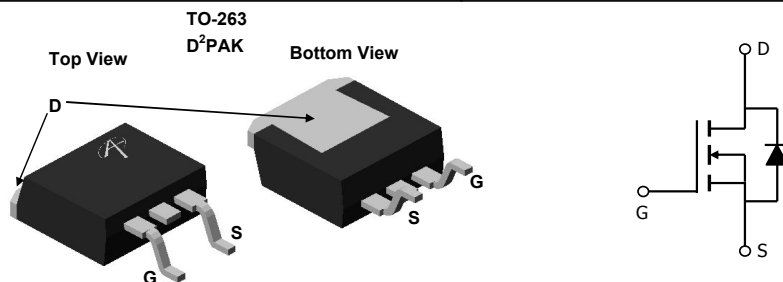
**AOB4184**  
**40V N-Channel MOSFET**
**General Description**

The AOB4184 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. With the excellent thermal resistance of the D<sup>2</sup>PAK package, this device is well suited for high current load applications.

**Features**

$V_{DS}$  (V) = 40V  
 $I_D$  = 50 A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 10 m $\Omega$  ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 13 m $\Omega$  ( $V_{GS}$  = 4.5V)

100% UIS Tested  
 100% Rg Tested


**Absolute Maximum Ratings**  $T_A=25^\circ\text{C}$  unless otherwise noted

| Parameter                                        | Symbol           | Maximum    | Units            |
|--------------------------------------------------|------------------|------------|------------------|
| Drain-Source Voltage                             | $V_{DS}$         | 40         | V                |
| Gate-Source Voltage                              | $V_{GS}$         | $\pm 20$   | V                |
| Continuous Drain Current <sup>G</sup>            | $I_D$            | 50         | A                |
| $T_C=25^\circ\text{C}$                           |                  | 40         |                  |
| Pulsed Drain Current <sup>C</sup>                | $I_{DM}$         | 120        |                  |
| Continuous Drain Current <sup>A</sup>            | $I_{DSM}$        | 12         |                  |
| $T_C=70^\circ\text{C}$                           |                  | 10         |                  |
| Avalanche Current <sup>C</sup>                   | $I_{AS}, I_{AR}$ | 35         | A                |
| Avalanche energy $L=100\mu\text{H}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 61         | mJ               |
| Power Dissipation <sup>B</sup>                   | $P_D$            | 50         | W                |
|                                                  |                  | 25         |                  |
| Power Dissipation <sup>A</sup>                   | $P_{DSM}$        | 2.5        | W                |
|                                                  |                  | 1.6        |                  |
| Junction and Storage Temperature Range           | $T_J, T_{STG}$   | -55 to 175 | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ | Max | Units                     |
|------------------------------------------|-----------------|-----|-----|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 11  | 17  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | 42  | 50  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Case <sup>B</sup>    | $R_{\theta JC}$ | 2.4 | 3   | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                                          | Conditions                                                                              | Min  | Typ         | Max      | Units |
|-----------------------------|----------------------------------------------------|-----------------------------------------------------------------------------------------|------|-------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                                    |                                                                                         |      |             |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                              | 40   |             |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =40V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                       |      |             | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                              |      |             | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                | 1.7  | 2.1         | 3        | V     |
| I <sub>D(ON)</sub>          | On state drain current                             | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                               | 120  |             |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                      |      | 8.5<br>13.2 | 10<br>17 | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                |      | 100         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                 |      | 0.72        | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |                                                                                         |      |             | 30       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                                    |                                                                                         |      |             |          |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz                                       | 1250 | 1500        | 1800     | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |                                                                                         | 165  | 215         | 280      | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                       |                                                                                         | 95   | 135         | 190      | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                        | 2    | 3.5         | 5        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                                    |                                                                                         |      |             |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =20A                         | 22   | 27.2        | 35       | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                                  |                                                                                         | 11   | 13.6        | 18       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |                                                                                         | 3.5  | 4.5         | 6        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |                                                                                         | 4.5  | 6.4         | 9        | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, R <sub>L</sub> =1Ω,<br>R <sub>GEN</sub> =3Ω |      | 6.4         |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |                                                                                         |      | 17.2        |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |                                                                                         |      | 29.6        |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |                                                                                         |      | 16.8        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =20A, dI/dt=500A/μs                                                      | 15   | 19          | 25       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =20A, dI/dt=500A/μs                                                      | 48   | 59          | 78       | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B: The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175°C.

D: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175°C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

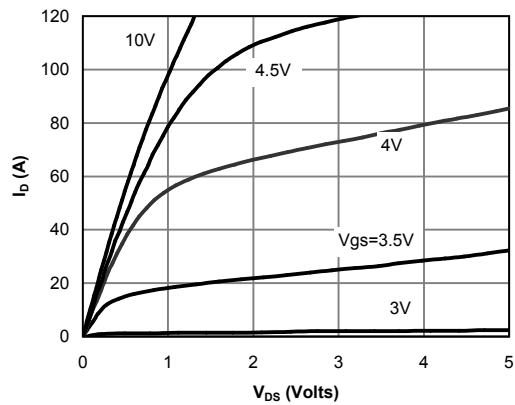


Figure 1: On-Region Characteristics

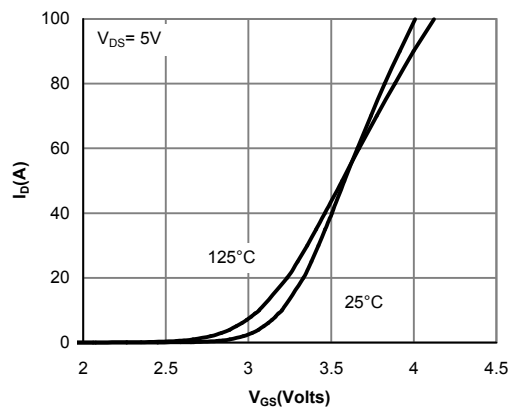


Figure 2: Transfer Characteristics

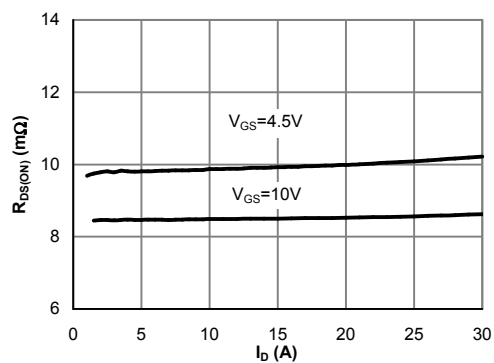


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

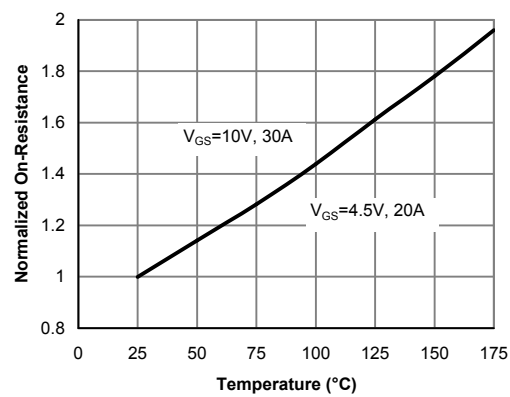


Figure 4: On-Resistance vs. Junction Temperature

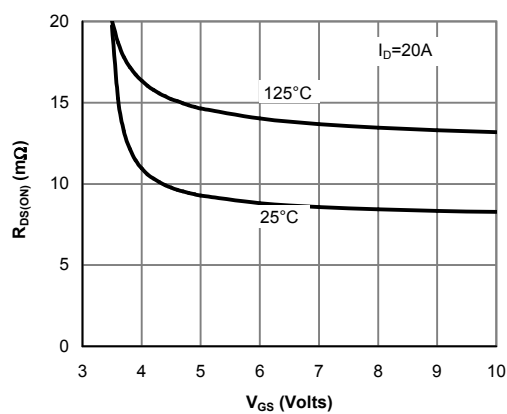


Figure 5: On-Resistance vs. Gate-Source Voltage

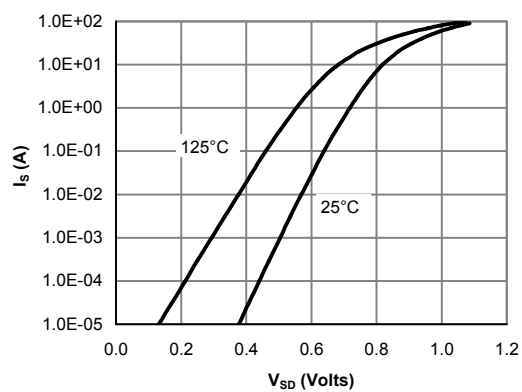


Figure 6: Body-Diode Characteristics

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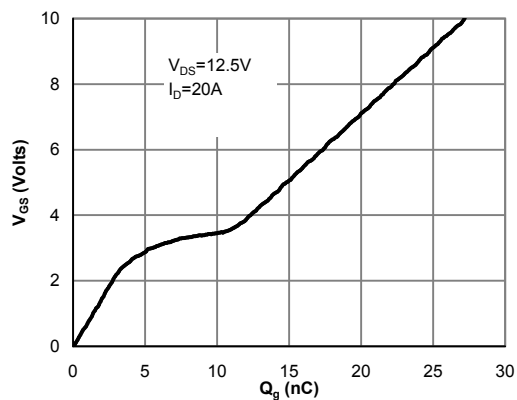


Figure 7: Gate-Charge Characteristics

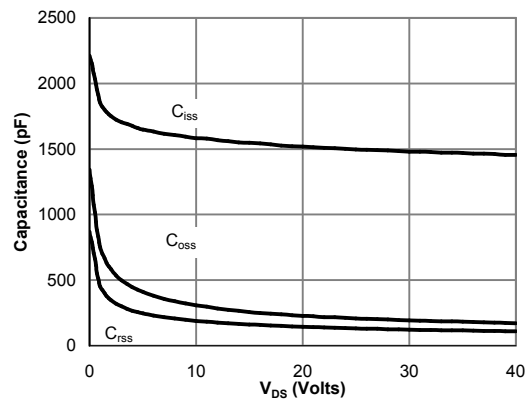


Figure 8: Capacitance Characteristics

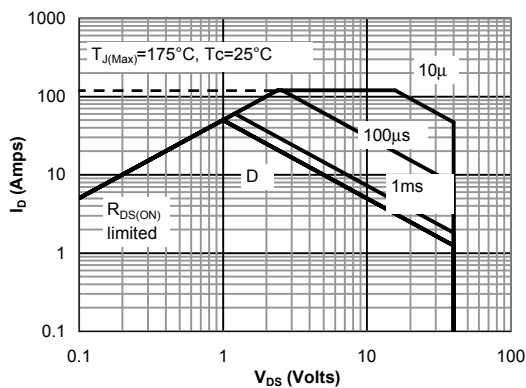


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

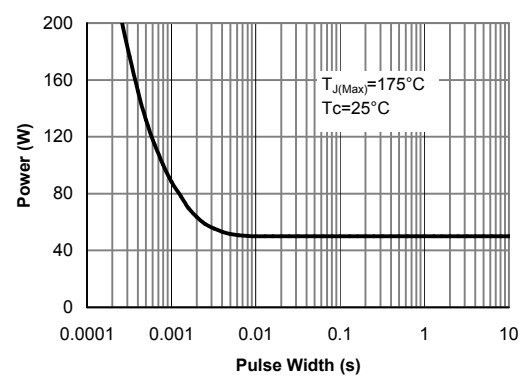


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

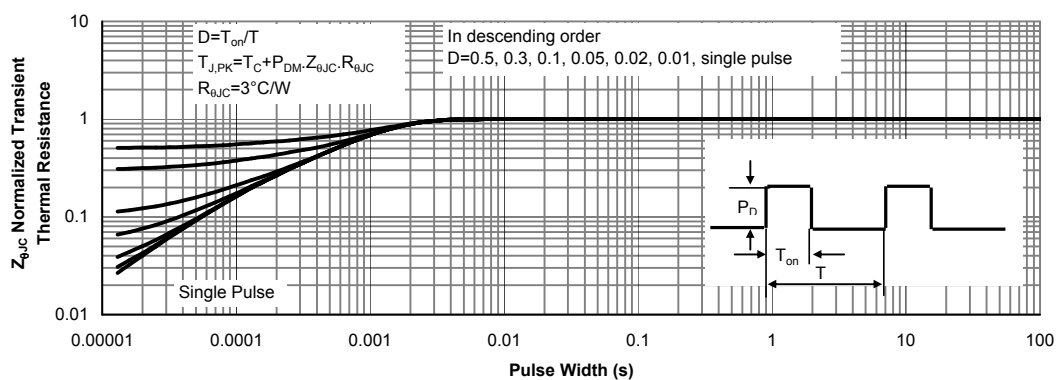


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

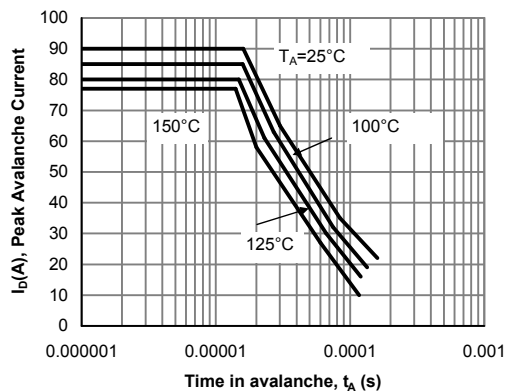


Figure 12: Single Pulse Avalanche capability

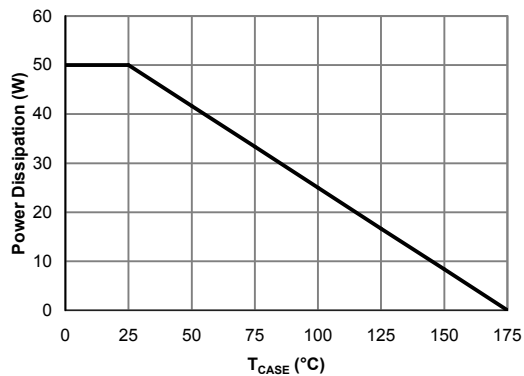


Figure 13: Power De-rating (Note F)

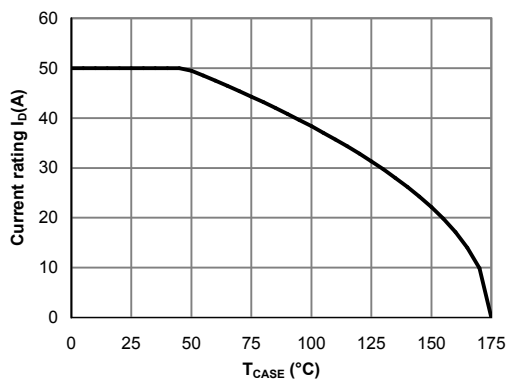


Figure 14: Current De-rating (Note F)

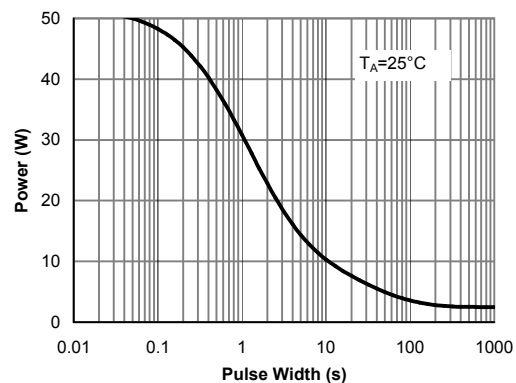


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

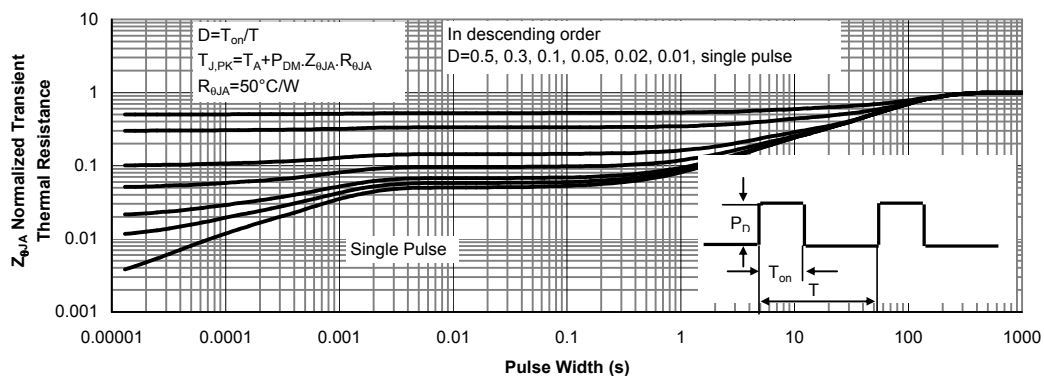
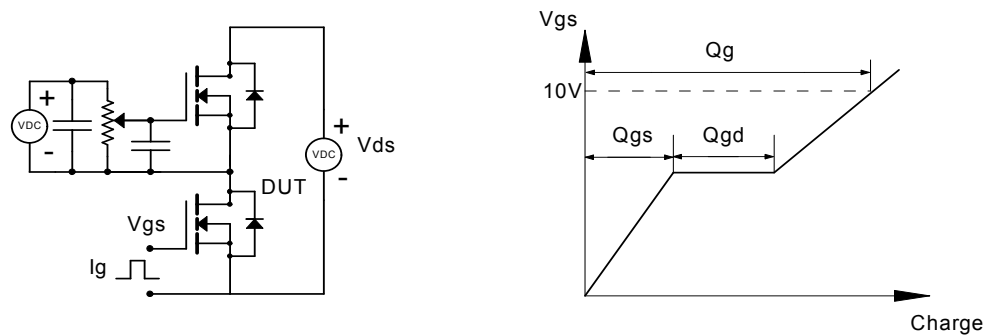
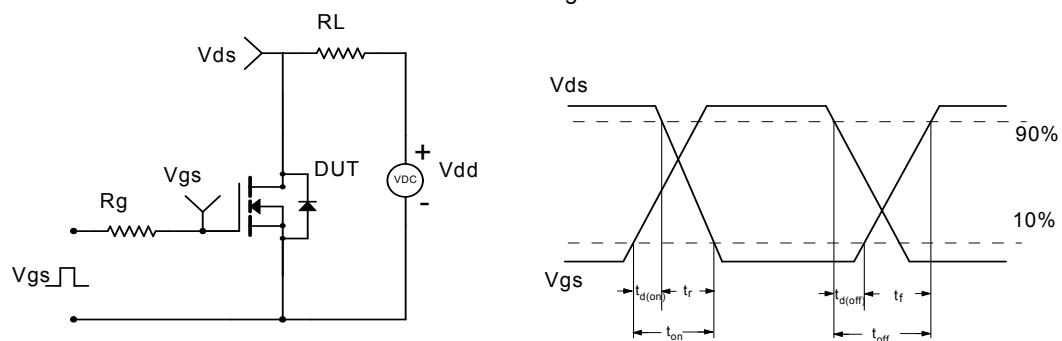


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

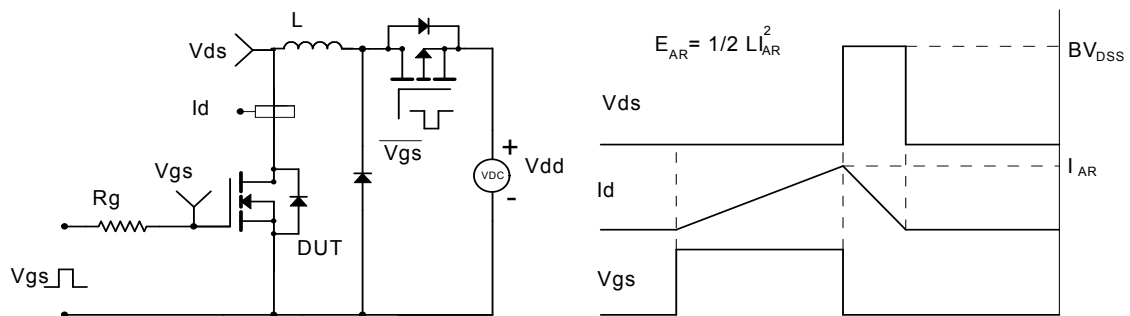
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

